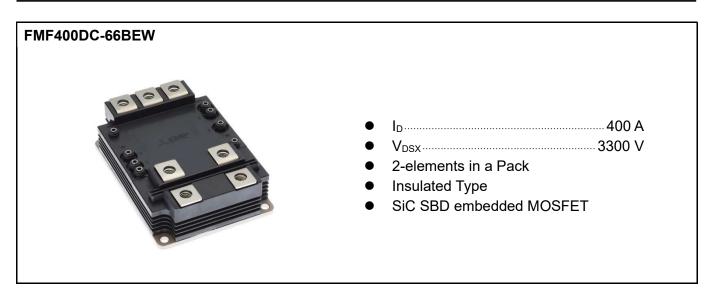


# FMF400DC-66BEW

**HIGH POWER SWITCHING USE** 

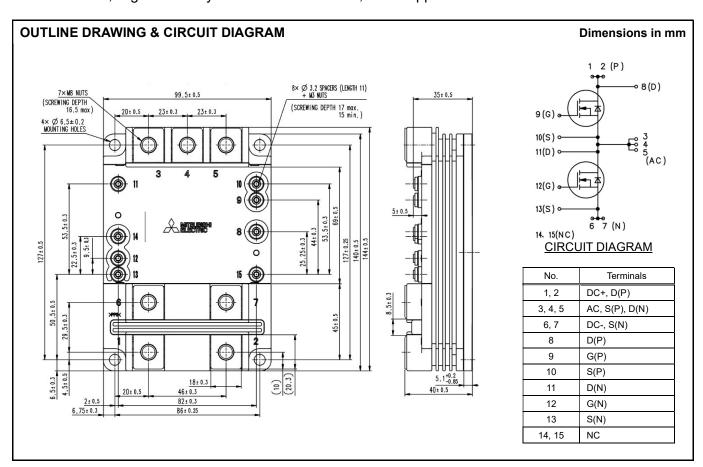
INSULATED TYPE

2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules



#### **APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers



## FMF400DC-66BEW

#### **HIGH POWER SWITCHING USE**

**INSULATED TYPE** 

2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **MAXIMUM RATINGS**

Item	Item Symbol Condition			Ratings	Unit	
Drain-Source voltage, specified gate-source voltage	V <sub>DSX</sub>	V <sub>GS</sub> = -7 V	3300	V		
Gate-Source voltage	V <sub>GSS</sub>	V <sub>DS</sub> = 0 V	T <sub>j</sub> = -40~175 °C	±20	٧	
Drain current	I <sub>D</sub>	$V_{GS}$ = 17 V , $T_c$ = 105 °C , AC terminal output current (Note 1)		400	Α	
Drain current	I <sub>DP</sub>	Non repetitive pulse	$T_j = T_{op}$	800		
Reverse drain current (FWD forward current)	Is	$V_{GS}$ = -7 V , $T_c$ = 103 °C , AC terminal output current(Note 1)(No	ote 2)	400	Α	
Reverse drain current (FWD forward current)	I <sub>SP</sub>	Non repetitive pulse(Note 2)	$T_j = T_{op}$	800	Α	
Total power dissipation	P <sub>tot</sub>	T <sub>c</sub> = 25 °C , MOSFET part(Note 3)		4160	W	
Isolation voltage	V <sub>isol</sub>	Charge part to the baseplate RMS sinusoidal, 60Hz 1min			V <sub>rms</sub>	
Partial discharge charge	Q <sub>pd</sub>	Charged part to the baseplate RMS sinusoidal, 60 Hz 1min V1 = 3500 V, V2 = 2600 V(acc. to IEC 61287-1)			рС	
Junction temperature	Tj	Maximum temperature range in off-state or on-state(non-switching)			°C	
Case temperature	T <sub>c</sub>	Maximum case temperature range in on-state		-40~150	°C	
Storage temperature	T <sub>stg</sub>	Maximum case temperature range in off-state		-50~175	°C	
Operating junction temperature	Operating junction temperature T <sub>jop</sub> Maximum junction temperature range for switching operation				°C	
Short-circuit withstand pulse duration	<b>t</b> <sub>pSC</sub>	V <sub>DD</sub> = 2500 V , V <sub>GS</sub> = +17 / -7 V , L <sub>s</sub> = 40 nH , V <sub>GS</sub> 50%-V <sub>GS</sub> 50%   T <sub>j</sub> = T <sub>op</sub>			μs	
Short circuit energy	Esc	$V_{DD} = 2500 \text{ V}$ , F(t)weibull=1% $T_j = T_{op}$		17.5	J	
Non-repetitive surge forward current	I <sub>FSM</sub>	T <sub>j</sub> = 175 °C			kA	
I2t value	l <sup>2</sup> t	T <sub>j</sub> = 175 °C			kA <sup>2</sup> s	

#### **ELECTRICAL CHARACTERISTICS**

Item	Symbol	Condition			Limits		Unit
iteiii	Symbol	Condition	Condition		Тур.	Max.	Offic
Gate-source leakage current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}$ , $V_{GS} = V_{GSS}$	T <sub>j</sub> = 25 °C	-1.0	-	1.0	μΑ
			T <sub>j</sub> = 25 °C	-	0.002	-	mA
Drain-source cut-off current	I <sub>DSX</sub>	$V_{DS} = V_{DSX}$ , $V_{GS} = -7 V$	T <sub>j</sub> = 150 °C	-	0.025	-	mA
			T <sub>j</sub> = 175 °C	-	0.040	1.5	mA
			T <sub>j</sub> = 25 °C	1.60	2.10	2.60	V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = 10 \text{ V}$ , $I_{D} = 40 \text{mA}$	T <sub>j</sub> = 150 °C	-	1.50	-	V
			T <sub>j</sub> = 175 °C	0.90	1.45	1.90	V
			T <sub>j</sub> = 25 °C	-	4.00	-	mΩ
Drain-source on resistance	r <sub>DS(on)</sub>	$V_{DS} = V_{DS(on)}$ , $V_{GS} = 17 V$	T <sub>j</sub> = 150 °C	-	8.63	-	mΩ
			T <sub>j</sub> = 175 °C	-	10.00	12.13	mΩ
			T <sub>j</sub> = 25 °C		1.60	-	V
Drain-source on-state voltage	$V_{DS(on)}$	I <sub>D</sub> = 400 A , V <sub>GS</sub> = 17 V , (Note 4)	T <sub>j</sub> = 150 °C	-	3.45	-	V
			T <sub>j</sub> = 175 °C	-	4.00	4.85	V
	V <sub>SD(on)</sub> I <sub>s</sub>	I <sub>S</sub> = 400 A , V <sub>GS</sub> = 17 V , (Note 4)	T <sub>j</sub> = 25 °C	-	1.45	-	V
Source-drain voltage			T <sub>j</sub> = 150 °C	-	3.25	-	V
			T <sub>j</sub> = 175 °C	-	3.80	4.40	V
			T <sub>j</sub> = 25 °C	-	2.00	-	V
Source-drain voltage	$V_{SD}$	I <sub>S</sub> = 400 A , V <sub>GS</sub> = 0 V , (Note 4)	T <sub>j</sub> = 150 °C	-	3.85	-	V
			T <sub>j</sub> = 175 °C	-	4.35	5.00	V
			T <sub>j</sub> = 25 °C	-	2.00	-	V
Source-drain voltage	$V_{SD(off)}$	I <sub>S</sub> = 400 A , V <sub>GS</sub> = -7 V , (Note 4)	T <sub>i</sub> = 150 °C	-	3.85	-	V
-			T <sub>i</sub> = 175 °C	-	4.35	5.00	V
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V , V <sub>GS</sub> = 0 V , f = 100kHz , 1/2 module	T <sub>j</sub> = 25 °C	-	55	-	nF
Output capacitance	Coss	V <sub>DS</sub> = 10 V , V <sub>GS</sub> = 0 V , f = 100kHz , 1/2 module	T <sub>j</sub> = 25 °C	-	35	-	nF
Reverse transfer capacitance	Crss	V <sub>DS</sub> = 10 V , V <sub>GS</sub> = 0 V , f = 100kHz , 1/2 module	T <sub>j</sub> = 25 °C	-	1.4	-	nF
Gate charge	Q <sub>G</sub>	$V_{DD}$ = 1800 V , $I_{D}$ = 400 A , $V_{GS}$ = +17 / -7 V , 1/2 module	T <sub>j</sub> = 25 °C	-	1.65	-	μC

## FMF400DC-66BEW

#### **HIGH POWER SWITCHING USE**

INSULATED TYPE

2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **ELECTRICAL CHARACTERISTICS**

Item	Symbol	Condition			Unit		
iteili	Symbol	Condition		Min.	Тур.	Max.	Offic
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 1800 \text{ V}$ , $I_D = 400 \text{ A}$ , $V_{GS} = +17 / -7 \text{ V}$ , $L_s = 40 \text{ nH}$	T <sub>j</sub> = 175 °C	-	-	0.41	μs
Rise time	tr	$V_{DD} = 1800 \text{ V}$ , $I_D = 400 \text{ A}$ , $V_{GS} = +17 \text{ / -7 V}$ , $L_s = 40 \text{ nH}$	T <sub>j</sub> = 175 °C	-	-	0.24	μs
		V <sub>DD</sub> = 1800 V , I <sub>D</sub> = 400 A , V <sub>GS</sub> = +17 / -7 V , L <sub>s</sub> = 40 nH	T <sub>j</sub> = 25 °C	-	0.13	-	J
Turn-on (switching) energy per pulse 10% integral	E <sub>on(10%)</sub>		$T_j = 150 {}^{\circ}\text{C}$	-	0.11	-	J
		$R_{G(on)}$ = 1.5 $\Omega$ , $R_{G(off)}$ = 3.0 $\Omega$ , Inductive load	T <sub>j</sub> = 175 °C	-	0.11	-	J
		V <sub>DD</sub> = 1800 V , I <sub>D</sub> = 400 A , V <sub>GS</sub> = +17 / -7 V , L <sub>s</sub> = 40 nH	T <sub>j</sub> = 25 °C	-	0.14	-	J
Turn-on (switching) energy per pulse	Eon	, - , - , - , -	$T_j = 150 {}^{\circ}\text{C}$	-	0.12	-	J
		$R_{G(on)}$ = 1.5 $\Omega$ , $R_{G(off)}$ = 3.0 $\Omega$ , Inductive load	T <sub>j</sub> = 175 °C	-	0.12	-	J
		$\begin{aligned} &V_{DD} = 1800 \text{ V} \text{ , I}_D = 400 \text{ A} \text{ , V}_{GS} = +17 \text{ / -7 V} \text{ , L}_s = 40 \text{ nH} \\ &R_{G(on)} = 1.5 \Omega \text{ , } R_{G(off)} = 3.0 \Omega \text{, Inductive load} \end{aligned}$	T <sub>j</sub> = 25 °C	-	5.4	-	μC
Total capacitive charge	$Q_{\mathbb{C}}$		T <sub>j</sub> = 150 °C	-	6.3	-	μC
			T <sub>j</sub> = 175 °C	-	6.3	-	μC
	E <sub>off_Diode(10%)</sub>	V <sub>DD</sub> = 1800 V , I <sub>D</sub> = 400 A , V <sub>GS</sub> = +17 / -7 V , L <sub>s</sub> = 40 nH	T <sub>j</sub> = 25 °C	-	0.80	-	mJ
Diode turn-off energy (per pulse)			T <sub>j</sub> = 150 °C	-	-	-	mJ
		$R_{G(on)}$ = 1.5 $\Omega$ , $R_{G(off)}$ = 3.0 $\Omega$ , Inductive load	T <sub>j</sub> = 175 °C	-	1.80		шJ
	E <sub>off_Diode</sub>	$V_{DD} = 1800 \text{ V}$ , $I_D = 400 \text{ A}$ , $V_{GS} = +17 / -7 \text{ V}$ , $L_S = 40 \text{ nH}$ $R_{C(ac)} = 1.5 \text{ O}$ , $R_{C(ac)} = 3.0 \text{ O}$ , Inductive load	T <sub>j</sub> = 25 °C	-	1.00	-	mJ
Diode switching off energy of diode			T <sub>j</sub> = 150 °C	-	-	-	mJ
			T <sub>j</sub> = 175 °C	-	2.00	-	mJ
Turn-off delay time	$t_{d(off)}$	$V_{DD} = 1800 \text{ V}$ , $I_D = 400 \text{ A}$ , $V_{GS} = +17 \text{ / -7 V}$ , $L_s = 40 \text{ nH}$	T <sub>j</sub> = 175 °C	-	-	0.94	μs
Fall time	t <sub>f</sub>	$V_{DD} = 1800 \text{ V}$ , $I_D = 400 \text{ A}$ , $V_{GS} = +17 / -7 \text{ V}$ , $L_s = 40 \text{ nH}$	T <sub>j</sub> = 175 °C	-	-	0.40	μs
		$V_{DD}$ = 1800 V , $I_D$ = 400 A , $V_{GS}$ = +17 / -7 V , $L_s$ = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 3.0 Ω, Inductive load	T <sub>j</sub> = 25 °C	-	0.05	-	J
Turn-off (switching) energy per pulse 10% integral	E <sub>off(10%)</sub>		T <sub>j</sub> = 150 °C	-	0.06	-	J
	, ,		T <sub>j</sub> = 175 °C	-	0.06	-	J
	E <sub>off</sub>	V <sub>DD</sub> = 1800 V , I <sub>D</sub> = 400 A , V <sub>GS</sub> = +17 / -7 V , L <sub>s</sub> = 40 nH	T <sub>j</sub> = 25 °C	-	0.05	-	J
Turn-off (switching) energy per pulse			T <sub>j</sub> = 150 °C	-	0.06	-	J
		$R_{G(on)}$ = 1.5 $\Omega$ , $R_{G(off)}$ = 3.0 $\Omega$ , Inductive load	T <sub>j</sub> = 175 °C	-	0.06	-	J

#### THERMAL CHARACTERISTICS

Item Symbo	Svmbol	Condition		Limits		
Tierri Symbol		Condition		Тур.	Max.	Unit
Thermal resistance junction to case	R <sub>th(j-c)</sub>	Junction to Case, MOSFET + embeded SBD part, 1/2 module	1	-	36.0	K/kW
Contact thermal resistance case to heatsink	R <sub>th(c-s)</sub>	Case to heat sink, $\lambda_{grease}$ = 1W/m·K, $D_{(c-s)}$ = 70 $\mu$ m, 1/2 module	-	28.5	-	K/kW

### FMF400DC-66BEW

#### **HIGH POWER SWITCHING USE**

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **MECHANICAL CHARACTERISTICS**

lt	Currents and	Condition		Limits			
Item	Symbol			Тур.	Max.	Unit	
Mounting torque	$M_{t}$	Main terminal screw M8 This is the case when installing the product on the bus bar		I	22.0	N·m	
Mounting torque	$M_t$	Mounting screw M6	3.0	-	6.0	N·m	
Mounting torque	Mt	uxiliary terminals screw M3 0.		-	0.8	N·m	
mass	m			0.8	-	kg	
Comparative tracking index	CTI	- 60		-	-	-	
Clearance distance in air	d <sub>a</sub>	Between main terminal 8.		-	-	mm	
Creepage distance along surface	ds	-	32.0	-	-	mm	
	L <sub>PDS</sub>	Between DC+ and DC- (terminal1,2-6,7)	-	17	-	nΗ	
Internal inductance, D-S	L <sub>PDS</sub>	Between DC+ and AC (terminal1,2-3,4,5)	-	45	-	nΗ	
	L <sub>PDS</sub>	Between AC and DC- (terminal3,4,5-6,7)	-	45	-	nΗ	

Note 1. Control Case Temperature (T<sub>C</sub>) so that the junction temperature (T<sub>j</sub>) does not exceed the maximum rating.

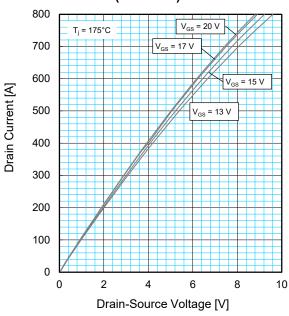
Products falling under the subject item No. 2 (41) 3 of Appended Table 1 of the Export Trade Control Order.

Note 2. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

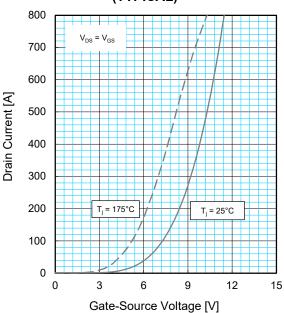
Note 3. Junction temperature  $(T_j)$  should not exceed  $T_{jmax}$  rating.

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

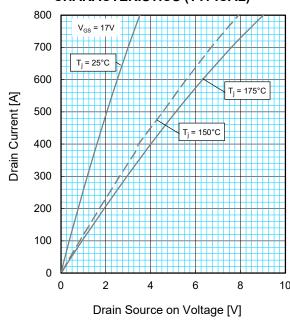
#### **OUTPUT CHARACTERISTICS** (TYPICAL)



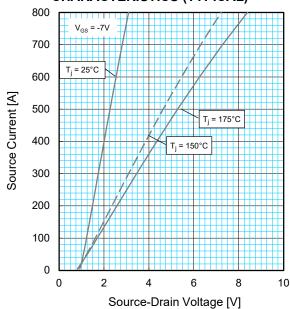
#### TRANSFER CHARACTERISTICS (TYPICAL)



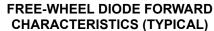
#### **DRAIN-SOURCE ON VOLTAGE CHARACTERISTICS (TYPICAL)**

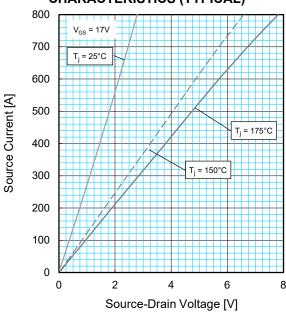


#### FREE-WHEEL DIODE FORWARD **CHARACTERISTICS (TYPICAL)**

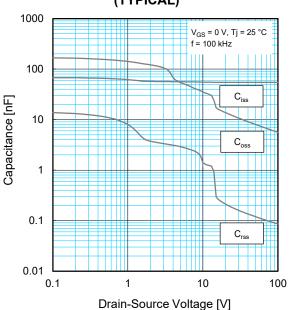


**PERFORMANCE CURVES** 

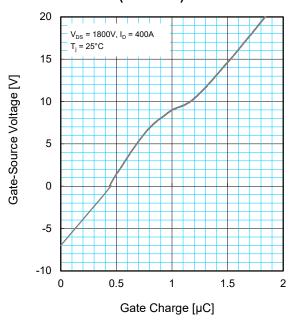




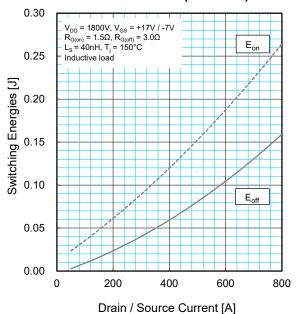
#### **CAPACITANCE CHARACTERISTICS** (TYPICAL)



#### **GATE CHARGE CHARACTERISTICS** (TYPICAL)



#### HALF-BRIDGE SWITCHING ENERGY **CHARACTERISTICS (TYPICAL)**

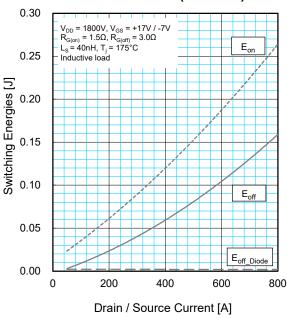


**HIGH POWER SWITCHING USE** 

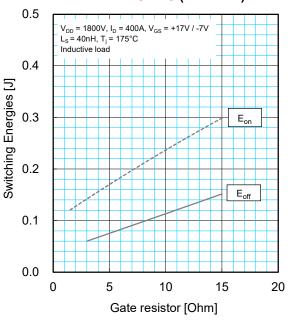
**INSULATED TYPE** 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

**PERFORMANCE CURVES** 

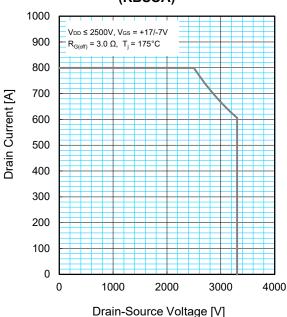
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



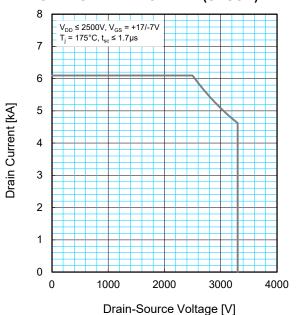
#### HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



# REVERSE BIAS SAFE OPERATING AREA (RBSOA)



# SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)

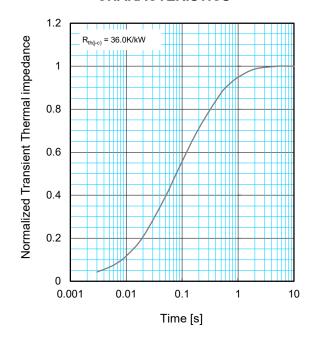


**HIGH POWER SWITCHING USE** 

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

**PERFORMANCE CURVES** 

# TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

	1	2	3	4
R <sub>i</sub> /R <sub>th</sub> :	0.0078	0.1975	0.3553	0.4393
τ <sub>i</sub> [sec.] :	0.0001	0.7324	0.0381	0.1698

**HIGH POWER SWITCHING USE** 

**INSULATED TYPE** 

2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

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HIGH POWER SWITCHING USE

**INSULATED TYPE** 

2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

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